## Application/Control No. 10/811,870 Applicant(s)/Patent Under Reexamination MARUYAMA, AKIRA Examiner Christopher S. Kim Applicant(s)/Patent Under Reexamination MARUYAMA, AKIRA Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,657,929	08-1997	DeWitt et al.	239/284.2
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	D	US-			
	E	US-			
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	К	US-			
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## **NON-PATENT DOCUMENTS**

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